

# TYPES SN5470, SN7470 AND-GATED J-K POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

REVISED DECEMBER 1983

- Package Options Include Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

## description

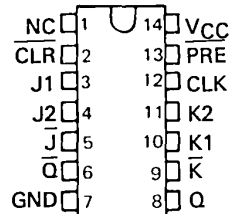
These monolithic, edge-triggered J-K flip-flops feature gated inputs, direct clear and preset inputs, and complementary Q and  $\bar{Q}$  outputs. Input information is transferred to the outputs on the positive edge of the clock pulse.

Direct-coupled clock triggering occurs at a specific voltage level of the clock pulse, and after the clock input threshold voltage has been passed, the gated inputs are locked out.

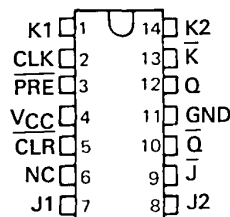
These flip-flops are ideally suited for medium-to-high-speed applications and can result in a significant saving in system power dissipation and package count where input gating is required.

The SN5470 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN7470 is characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .

SN5470 ... J PACKAGE  
SN7470 ... J OR N PACKAGE  
(TOP VIEW)

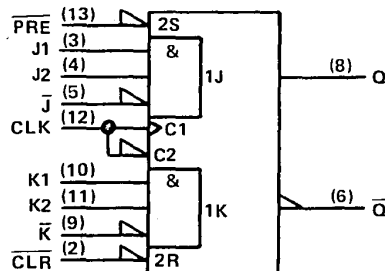


SN5470 ... W PACKAGE  
(TOP VIEW)



NC - No internal connection

## logic symbol



Pin numbers shown are for J and N packages only.

## positive logic

$$J = J1 \cdot J2 \cdot \bar{J}$$

$$K = K1 \cdot K2 \cdot \bar{K}$$

INPUTS					OUTPUTS	
PRE	CLR	CLK	J	K	Q	$\bar{Q}$
L	H	L	X	X	H	L
H	L	L	X	X	L	H
L	L	X	X	X	L <sup>†</sup>	L <sup>†</sup>
H	H	↑	L	L	Q <sub>0</sub>	$\bar{Q}_0$
H	H	↑	H	L	H	L
H	H	↑	L	H	L	H
H	H	↑	H	H	TOGGLE	
H	H	L	X	X	Q <sub>0</sub>	$\bar{Q}_0$

If inputs J and K are not used, they must be grounded. Preset or clear function can occur only when the clock input is low.

<sup>†</sup>This configuration is nonstable; that is, it will not persist when preset and clear inputs return to their inactive (high) level.

**PRODUCTION DATA**  
This document contains information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

TEXAS  
INSTRUMENTS

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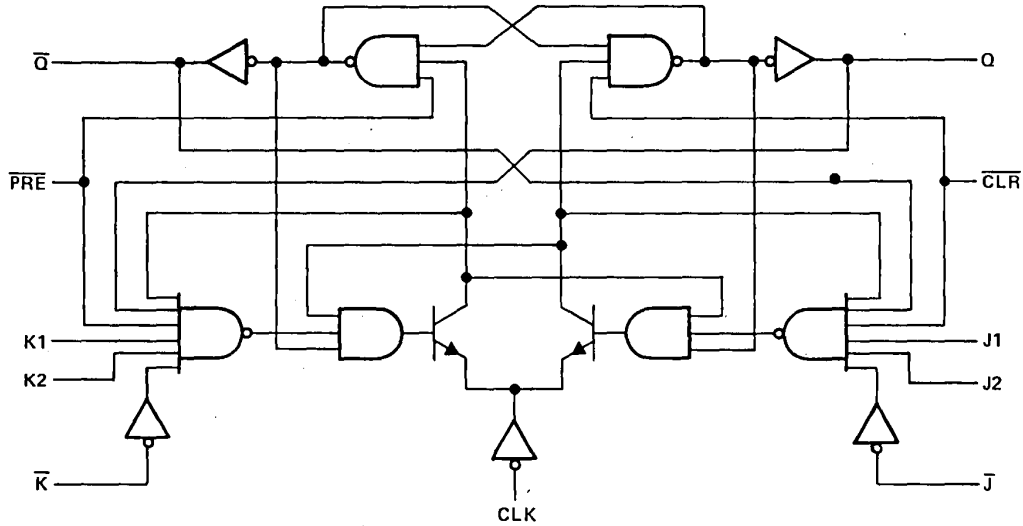
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TTL DEVICES

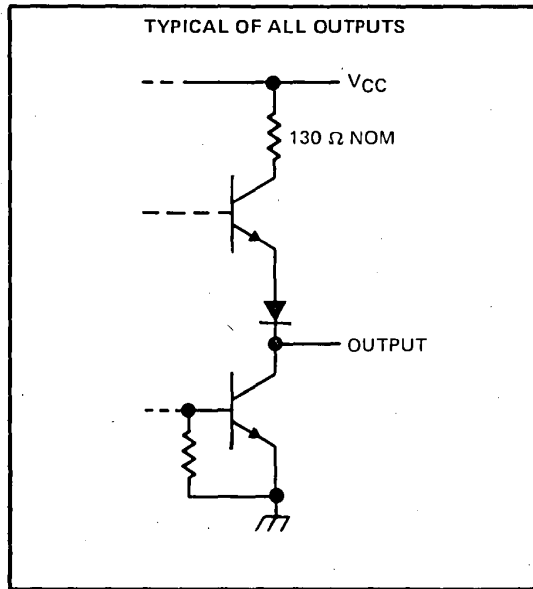
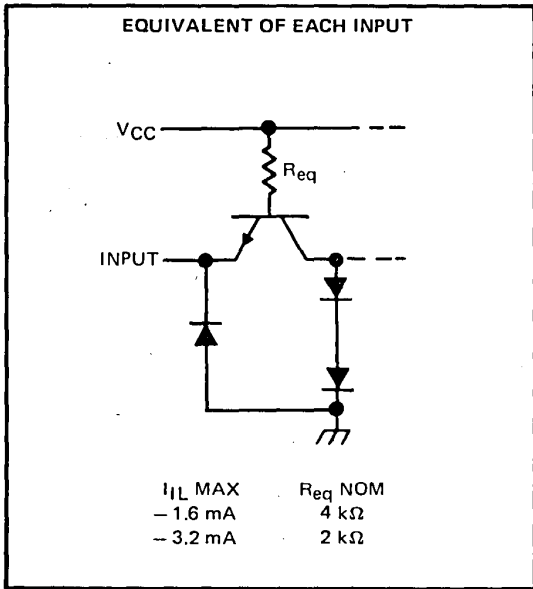
**TYPES SN5470, SN7470**  
**AND-GATED J-K POSITIVE-EDGE-TRIGGERED**  
**FLIP-FLOPS WITH PRESET AND CLEAR**

logic diagram



'70-GATED J-K WITH CLEAR AND PRESET

schematics of input and outputs



**3**  
**TTL DEVICES**

# TYPES SN5470, SN7470

## AND-GATED J-K POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, $V_{CC}$ (see Note 1) .....	7 V
Input voltage .....	5.5 V
Operating free-air temperature: SN5470 .....	-55°C to 125°C
SN7470 .....	0°C to 70°C
Storage temperature range .....	-65°C to 150°C

NOTE 1: All voltage values are with respect to network ground terminal.

### recommended operating conditions

	SN5470			SN7470			UNIT		
	MIN	NOM	MAX	MIN	NOM	MAX			
$V_{CC}$ Supply voltage	4.5	5	5.5	4.75	5	5.25	V		
$V_{IH}$ High-level input voltage	2			2			V		
$V_{IL}$ Low-level input voltage			0.8			0.8	V		
$I_{OH}$ High-level output current			-0.4			-0.4	mA		
$I_{OL}$ Low-level output current			16			16	mA		
$t_w$ Pulse duration	CLK high		20	20		ns			
	CLK low		30	30					
	PRE or CLR low		25	25					
$t_{su}$ Setup time before CLK ↑			20			ns			
$t_h$ Hold time-Data after CLK ↑			5			ns			
$T_A$ Operating free-air temperature			-55			125	0	70	°C

† The arrow indicates the edge of the clock pulse used for reference: ↑ for the rising edge, ↓ for the falling edge.

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN5470			SN7470			UNIT
		MIN	TYP‡	MAX	MIN	TYP‡	MAX	
$V_{IK}$	$V_{CC} = \text{MIN}, I_I = -12 \text{ mA}$			-1.5			-1.5	V
$V_{OH}$	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = -0.4 \text{ mA}$	2.4	3.4		2.4	3.4		V
$V_{OL}$	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = 16 \text{ mA}$		0.2	0.4		0.2	0.4	V
$I_I$	$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			1			1	mA
$I_{IH}$	PRE or CLR			80			80	μA
	All other	$V_{CC} = \text{MAX}, V_I = 2.4 \text{ V}$		40			40	
$I_{IL}$	PRE or CLR*	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$		-3.2			-3.2	mA
	All other			-1.6			-1.6	
$I_{OS}§$	$V_{CC} = \text{MAX}$	-20		-57	-18		-57	mA
$I_{CC}$	$V_{CC} = \text{MAX},$ See Note 2		13	26		13	26	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at  $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ .

§ Not more than one output should be shorted at a time.

\* Clear is tested with preset high and preset is tested with clear high.

NOTE 2: With all outputs open,  $I_{CC}$  is measured with the Q and  $\bar{Q}$  outputs high in turn. At the time of measurement, the clock input is at 4.5 V.

3

TTL DEVICES

**TYPES SN5470, SN7470  
AND-GATED J-K POSITIVE-EDGE-TRIGGERED  
FLIP-FLOPS WITH PRESET AND CLEAR**

switching characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (see note 3)

PARAMETER†	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_{\text{max}}$			$R_L = 400\ \Omega$ , $C_L = 15\ \text{pF}$	20	35		MHz
$t_{\text{PLH}}$	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$	Q or $\overline{\text{Q}}$				50	ns
$t_{\text{PHL}}$						50	ns
$t_{\text{PLH}}$	CLK	Q or $\overline{\text{Q}}$			27	50	ns
$t_{\text{PHL}}$					18	50	ns

†  $f_{\text{max}}$  = maximum clock frequency;  $t_{\text{PLH}}$  = propagation delay time, low-to-high level output;  
 $t_{\text{PHL}}$  = propagation delay time, high-to-low level output.

NOTE 3: See General Information Section for load circuits and voltage waveforms.